Investigation of Superlattice Surface Characteristics



Completed Technology Project (2016 - 2020)

Project Introduction

This research will remove the major obstacle to realizing the full potential of infrared (IR) photodetectors using strained-layer superlattice (SLS) absorbers. Modeling of the SLS surfaces will be performed by the simultaneous solution of the Poisson and Schroedinger equations. This will yield the surface characteristics and conductivity types of selected SLS structures. Growth of SLS structures will be performed by molecular beam epitaxy. Crystal quality will be assessed with x-ray diffraction, photoluminescence, and atomic force microscopy. Interface quality will be assessed with transmission electron microscopy. Processing of complete IR photodetectors with SLS absorber regions will be performed using standard photolithography techniques. Device performance will be assessed with temperature-dependent current-voltage characteristics, surface conductivity measurements, and calibrated photocurrent response measurements. This research addresses one of the requirements of TABS element 8.1.1, that of large focal-plane array detectors with low noise. It addresses this requirement by investigating the surface characteristics of SLS structures in order to design a detector that correctly suppresses surface leakage currents. By combining the unipolar barrier with an SLS absorber, an IR detector can be created with high QE, suppressed band-to-band tunneling, reduced Auger generation, and an arbitrarily long cutoff wavelength.

Anticipated Benefits

By combining the unipolar barrier with an SLS absorber, an IR detector can be created with high QE, suppressed band-to-band tunneling, reduced Auger generation, and an arbitrarily long cutoff wavelength.



Investigation of Superlattice Surface Characteristics

Table of Contents

Project Introduction	1	
Anticipated Benefits		
Organizational Responsibility		
Primary U.S. Work Locations		
and Key Partners	2	
Project Management		
Technology Maturity (TRL)	2	
Technology Areas	2	
Target Destination	2	

Organizational Responsibility

Responsible Mission Directorate:

Space Technology Mission Directorate (STMD)

Lead Organization:

University of Rochester

Responsible Program:

Space Technology Research Grants

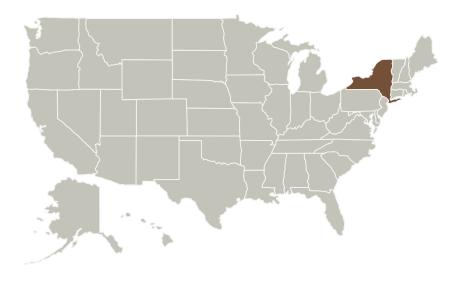


Investigation of Superlattice Surface Characteristics



Completed Technology Project (2016 - 2020)

Primary U.S. Work Locations and Key Partners



Organizations Performing Work	Role	Туре	Location
University of Rochester	Lead Organization	Academia	Rochester, New York

Primary U.S. Work Locations

New York

Project Management

Program Director:

Claudia M Meyer

Program Manager:

Hung D Nguyen

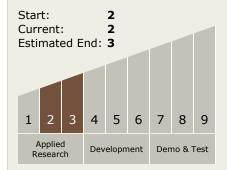
Principal Investigator:

Gary Wicks

Co-Investigator:

Brendan Marozas

Technology Maturity (TRL)



Technology Areas

Primary:

- TX08 Sensors and Instruments
 - ☐ TX08.1 Remote Sensing Instruments/Sensors
 - ─ TX08.1.1 Detectors and Focal Planes

Target Destination

Foundational Knowledge

